


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590585	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAHASHI ET AL.
	<b>Examiner</b>  David K O'Dell	<b>Art Unit</b>  1625

SEARCHED			
Class	Subclass	Date	Examiner
546	148, 177, 178, 179, 196, 200	02/24/2010	dko
544	363	02/24/2010	dko

SEARCH NOTES		
Search Notes	Date	Examiner
STN, EAST, PALM	02/24/2010	dko

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/David K O'Dell/ Examiner.Art Unit 1625	
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